

Search Notes

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Phillip Nguyen

Applicant(s)/Patent under
Reexamination

SHIN ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
372	18, 29.01, 29.02, 29.022	5/26/2006	PN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
see the search history		5/26/2006	PN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search (see the search history)	5/26/2006	PN